

Fluke Calibration Certificates

Application Note

A guide to understanding different types of calibration certificates and certificate terminology

Fluke Corporation is a supplier of a variety of electronic testing and measurement instruments. Fluke is also a provider of precision measurement instrumentation used as calibrators and standards in various areas of metrology. Additionally, Fluke provides repair and calibration services for many different test instruments. In each of these roles, providing calibration certificates plays a part which is very important, but sometimes different.

Also, Fluke is a company with a presence throughout the world. Original manufacturing is done from a series of worldwide factories. Additionally, the calibration and repair services are done at different authorized service centers throughout the counties from which Fluke serves its customers. Out of this manufacturing and service network there can be seen variations in the calibration certificates that Fluke provides.

While these variations are very reasonable and acceptable, the differences do raise questions from users of the test instruments. Fluke frequently is asked questions about what different types of calibration and testing reports are available with our products and services, what the different reports are, what reports and certificates accompany new instruments and what are available optionally. The most important issue is to determine what type of report will best meet the needs of the customer.

This guide answers frequently asked questions and provides general information about the calibration and test reports available from Fluke. It should be noted that reports of calibration evolve over time and Fluke has the right to change some aspects of these reports, as needed, and at any time.

What report types are available with Fluke's instrumentation and what are the purposes of these documents?

Reports on instrument performance supplied with Fluke's instruments can range from simple documents that certify that a general testing philosophy was applied to a particular instrument, to very detailed calibration reports that outline specific testing details intended to satisfy formal guidelines or requirements. Performance reports available from Fluke include:

1) Statement of calibration practices

A statement of calibration practices is not a formal calibration certificate. This document commonly accompanies most newly purchased test instruments that are of a general purpose nature. It attests that the quality control, testing, and calibration of this particular instrument were done according to Fluke's quality standards, and the instrument will meet its published specifications. The tests were conducted using instrumentation and systems with calibrations traceable

FLUKE.



Fluke Corporation hereby certifies that this product was calibrated in accordance with applicable Fluke calibration procedures during the manufacturing process. These procedures are ISO-9001 controlled and are designed to assure that the instrument will meet its published specification.

Fluke Corporation further certifies that the measurement standards and instruments used during the calibration of this product are traceable to the United States National Institute of Standards and Technology (NIST). At planned intervals, Fluke's measurement standards are calibrated by comparison to or measurement against the standards at NIST. This document is not a certificate of calibration or traceability.

To obtain a certificate of calibration, contact your nearest Fluke Service Center to process an order to have your unit sent in for calibration. A nominal fee is charged for calibration service.

Quality Assurance Manager Fluke Corporation

P/N 1554590 Rev. 2 12/2003

Figure 1. Statement of calibration practices.

to national and international standards. However, because such testing and calibration is done in a high volume production environment, no specific calibration certificate is available and no details of the testing can be provided. If a calibration certificate is required, a separate calibration must be done following production—usually at an extra charge. An example of this documentary statement is included in Figure 1.



2) Certificate of traceable calibration (without data)

This document certifies that a specific instrument, identified by model and serial number, was tested using Fluke's applicable procedures, in accordance with Fluke's quality standards, and the instrument met published specifications. "Without data" means that the report contains general information, such as instrument details and specific testing dates, but does not include test point measurement details. With this type of calibration, the procedure does perform the required test operations and evaluates the instrument for proper performance, but none of the test data is retained for future reference. This type of certificate is usually available only upon request from a service center. New instruments typically do not come with this certificate type. An example of this document is included in Figure 2.

3) Certificate of traceable calibration with data

This document certifies that a specific instrument, identified by model and serial number, was tested using Fluke's applicable procedures, in accordance with Fluke's quality standards. The calibration was done with calibrating standards traceable to national and international standards. Specific testing dates and specific testing instrumentation details are provided. Details of the individual tests are also provided, with a variety of supporting information. These details are intended for future reference when evaluating instrument performance or assisting with corrective actions. Details may include some or all of these parameters: specific test points, appropriate specification limits, measured values, test ratio information, measurement uncertainty. Other parameters may be included as well, depending upon various quality and metrology requirements.

Within this category, there are different classes of certificates. They range from supplying details that generally satisfy commonly needed reporting requirements, to others that specifically satisfy various formal requirements for calibration certificates.

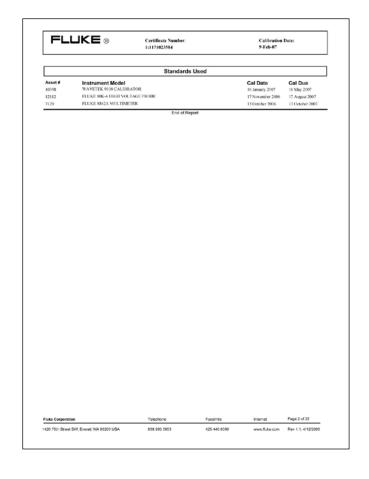
This type of certificate includes, but is not limited to these common certificates:

- o Traceable calibration certificates with data
- o Z540 calibration certificates
- o Accredited report of calibration

Descriptions and general details of these are provided on the next page.



Figure 2. Certificate of traceable calibration.



Traceable calibration certificate with data

This calibration certificate documents that a specific instrument, identified by model and serial number, was tested using Fluke's applicable procedures. The processes ensure testing with traceability to national and international standards, but do not necessarily fulfill all requirements of various formal standards, such as Z540.1 or 17025. Hence it is considered "generic," simply a Traceable Calibration Certificate that includes test data. Details of the individual tests are provided with an appropriate set of supporting information. An example of this document is included in Figure 3.

CERTIFICATE OF CALIBRATION

ISSUED BY

FLUKE

F14983 Certificate No Issue Date: 22 Jan 2007

Page: Signature:

he Approved Signatory: R. A. Bull

Page 1 of 14

Measurement Date: 14 January 2007 14 January 2007 Date of Receipt:

Model Type Number: Reference Multimeter

Instrument Serial No: 932654019 Fluke Manufacturer:

This Certificate indicates the data recorded after adjustment of the instrument.

The instrument has been calibrated in accordance with the manufacturer's Instrument User's Handbook using standards that are directly traceable to National Standards maintained at the National Physical Laboratory, Teddington. The reported expanded uncertainty is based on a standard uncertainty multiplied by a coverage factor k=2, providing a level of confidence of approximately 95%. The uncertainty evaluation has been carried out in accordance with UKAS M3003 and the ISO Guide to the Expression of Uncertainty in Measurement and is inclusive of the unit under lest. The uncertainties relate only to the measured values and do not carry any implication regarding the long term stability of the instrument.

The measurements were made at a room temperature of 23.0 ± 1.0 °C and a relative humidity of 40% ± 10%

This provides traceability of measurement to recognised national standards, and to the units of measurement resided at the National Physical Laboratory or other recognised coefficials may not be represented other than in full, except with the prior written approval of the issuing laboratory.

Figure 3. Traceable Calibration Certificate with Data

CERTIFICATE OF CALIBRATION

FLUKE PRECISION MEASUREMENT LTD. FURRICIANE WAY MORNICH NORFOLK NAS A.R. UNITED KINGDÓN TELEPHONE - MACINGO 2000C FAX: «MOLINO) MORIO

Page 2 of 14

Reporting Compliance With Specification

The following pages contain the calibration results with two further columns indicating the instrument performance relative to the stated specification.

The column headed % of Spec' is the measured error as a percentage of the stated specification with no allowabeing made for the calibration uncertainty.

The column headed 'Compliance With Spec' indicates compliance or otherwise with specification taking into account the measurement uncertainty, the five possible conditions are indicated as follows:

The equipment complies with the stated specification at the measured points, due allowance having been made for the uncertainty of the measurements.

The measurement result is within the specification limit by a margin less than the measurement uncertainty; it is therefore not possible to state compliance based on the stated level of confidence. However the results indicate that compliance is more probable than non-compliance with the specification limit.

The measurement result is outside the specification limit by a margin less than the measurement uncortainty; it is therefore not possible to state non-compliance based on the the stated level of confidence. However the results indicate that non-compliance is more probable than compliance with the specification limit.

The equipment does not comply with the stated specification at the measured points, due allowance having been made for the uncertainty of the measurements.

The uncertainty is greater than the stated specification, it is therefore not possible to determine compliance or otherwise with the stated specification.

Zero Measurements

For all zero measurements the applied value is a calibration system zero which is used to cancel any system offset. The assigned uncertainty for these measurements represents the precision of the zero setting rather than the absolute value.

Specification Used: Adjustment and Measurement

Procedure Used: Fluke 8508A:5720A VER & VERADJ: 6.03

Standards Used

Asset Number	Instrument Model	Car Date	Cal Due Date
C1/620A	Fluke 5725A	24 Nov 2006	24 Jan 2007
C1/621A	Fluke 5700A	24 Nov 2006	23 Jan 2007
C1/633A	Fluke 8508A-7000K	04 Dec 2006	02 Mar 2007

CERTIFICATE OF CALIBRATION

FLUNC PRECISION MEASUREMENT LTD. HURPICANE WAY NORMICH NORFOLK ARE GIB, UNITED KINGDOM. TILLEPHONE: HARDYIGO JORGO FAX: HARDYIGO BORDO.

Adjustment and Measurement Specification Period 24 Hour UUT Firmware Version : 02.06

DC Voltage - Gain Configuration: 7 digit Resolution, Filter off, Fast off, Local Guard, Front Input.

Range	Applied Value		Indicated Value	ı	Deviation		Expanded Uncertainty	% of Spec	Compliance with Spec
200 nV	0.000000	Vm	-0.00002	υV	-0.000018	πV	8.0 x10-5 mV	189	
200 nV	99.999890	πV	99,99986	n.V	-0.000028	'nν	3.4 ×10-4 mV	351	N/A
200 nV	-99,999910	Vm	-99.99991	υV	0.0000021	υV	3.4 x10-4 mV	21	N/A
2 V	0.00000000	V	-0.0000001	V	-0.00000006	v	2.0 x10-7 V	15%	
2 V	0.99999790	V	0.9999977	v	-0.00000020	v	8.0 x10-7 V	339	N/A
2 V	-0.99999860	V	-0.9999985	V	0.00000010	V	8.0 x10-7 V	168	N/A
20 V	0.0000000	V	0.000001	v	0.0000006	v	2.0 x10-6 V	159	
20 V	9.9999730	V	9,999973	v	-0.0000002	V	7.0 x10-6 V	31	N/A
20 V	-9.9999760	V	-9.999976	v	-0.0000002	v	7.0 x10-6 V	31	N/A
200 V	0.000000	V	-0.00001	v	-0.000006	v	2.0 x10-5 V	158	
200 V	100.000290	V	100.00028	v	-0.000010	v	7.0 x10-5 V	81	
200 V	-100.000290	v	-100.00028	v	0.000008	v	7.0 x10-5 V	68	
1000 V	0.00000	V	0.0000	v	0.00004	v	2.0 x10-4 V	81	
1000 V	999.99900	V	999,9989	ν	-0.00012	v	1.1 ×10-3 V	10%	
1000 V	-999,99890	v	-999.9988	ν	0.00012	v	1.1 x10-3 V	108	

20V Range Linearity
The Indicated Value shown below is the UUT reading

after offset & gain correction.

Configuration: 7 digit Resolution, Filter off, Fast off, Local Guard, Front Input.

Range	Applied Value		Indicated Value	1	Deviation			cpandec certaint		% of Spec	Compliance with Spec
20 V	0.0000000	v	0.000001	ν	0.0000014	v	1.0	x10-6	V	28%	
20 V	0.0000100	V	0.000011	v	0.0000008	ν	1.0	x10-6	V	16%	
20 V	0.0001000	V	0.000101	v	0.0000006	ν	1.0	×10-6	v	12%	
20 V	0.0010000	V	0.001001	ν	0.0000006	ν	1.0	x10-6	V	12%	
20 V	0.0100000	V	0.010001	ν	0.0000008	ν	1.0	x10-6	V	16%	
20 V	0.1000000	V	0.100000	v	0.0000003	v	1.0	×10-6	ν	58	
20 V	1.0000000	v	1.000000	v	-0.0000001	ν	1.0	×10-6	ν	28	
20 V	5.0000000	V	4.999999	v	-0.0000014	ν	1.9	×10-6	ν	28%	
20 V	10.0000000	v	9.999998	v	-0.0000019	v	3.4	×10-6	ν	378	
20 V	15.0000000	V	15.000000	v	-0.0000001	ν	4.9	×10-6	ν	19	
20 V	19.0000000	v	19.000003	v	0.0000028	ν	6.1	×10-6	ν	568	N/A
20 V	0.0000000	v	-0.000000	ν	-0.0000002	ν	1.0	×10-6	ν	4.8	
20 V	-0.0000100	v	-0.000009	v	0.0000006	ν	1.0	×10-6	ν	12%	
20 V	-0.0001000	V	-0.000099	v	0.0000010	ν	1.0	×10-6	ν	20%	
20 V	-0.0010000	v	-0.000999	ν	0.0000010	ν	1.0	×10-6	ν	20%	
20 V	-0.0100000	v	-0.009999	v	0.0000010	v	1.0	×10-6	ν	198	
20 V	-0.1000000	v	-0.099999	v	0.0000008	ν	1.0	x10-6	ν	15%	

Z540 calibration certificate

Commonly referred to as a Z540 certificate, this is more properly termed a Z540.1 calibration certificate. It documents that a specific instrument, identified by model and serial number, was tested using Fluke's applicable procedures, traceable to national and international standards, in accordance with formal American Standard named Z540.1. (More specifically, its present version is named ANSI/NCSL Z540.1-1994 (R2002) Part I.) With this certificate, details of the individual tests are provided with a variety of supporting information. These details may include some or all of, but are not limited to, the specific test points, the appropriate specification limits, measured values, etc. It doesn't usually include specific measurement uncertainty information, but rather does enumerate test cases where accuracy ratios between the test tolerances and the associated standard are less than four to one. Also included are specific testing dates, specific testing instrumentation details and traceability information. An example of this document is included in Figure 4.

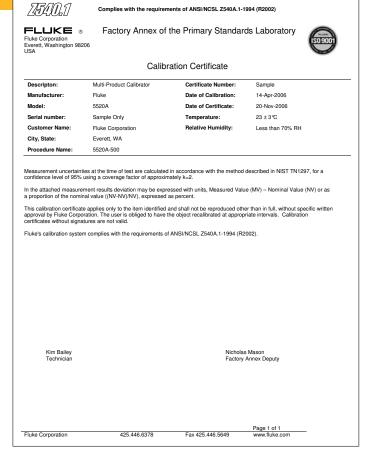


Figure 4. Z540 calibration certificate

Certificate Number: F3128001 Date of Certificate: 20-Nov-2006 Page 2 of 8

Traceability Information

DC Voltage

This calibration was conducted using an unbroken chain of standards to the Fluke Volt, which is traceable to the U.S. representation of the volt, through the internationally accepted value of the Josephson constant Kj

Frequency
This calibration was conducted using an unbroken chain of standards to a GPS disciplined oscillator frequency standard, traceable to the United States Naval Observatory (USNO), which is traceable to the National Institute of Standards and Technology (NIST).

AC Voltage (1 MHz and below), Resistance, DC Current, AC Current (10 mA and above), Capacitance, Inductance and Phase
This calibration was conducted using an unbroken chain of standards which are traceable to NIST.

AC Voltage (> 1 MHz) and RF Power
This calibration was conducted using an unbroken chain of standards which are traceable to NIST or the National Research

AC Current (< 10 mA)
This calibration was conducted using an unbroken chain of standards which are traceable to Physikalisch Technische Bundesanstat (PTB) (German National Metrology Institute).

Temperature
This calibration was conducted using an unbroken chain of standards to the Hart Scientific Metrology Laboratory, which is traceable to NIST and/or to Hart maintained intrinsic standards.

Humidity
This calibration was conducted using an unbroken chain of standards traceable to the Fluke Everett Service Center, whose traceability is based on the physical phenomena in which the equilibrium relative humidity values associated with certain saturated sail solutions are known.

Fluke Corporation 425.446.6378 Fax 425.446.5649 www.fluke.com

Certificate Number: F3128001	Date of Certificate:	20-Nov-2006		Page 3 of 8
Standards Used				
PM0 2				
C Voltage				
utput/Range V, 330 mV -329 mV, 330 mV -329 mV, 330 mV V, 3.30 V -1 V, 3.30 V	Measurement	Deviation	TUR	90 Day Spec
V, 330 mV	231.169 nV	0.231 uV	1.7	1.000 µV
129 mV, 330 mV	329.000 mV	0.000 %		0.002 %
-329 mV, 330 mV	-328.998 mV	0.000 %		0.002 %
) V, 3.30 V	66.681 nV	0.067 uV	3.0	2.000 μV
. V, 3.30 V	999.998 mV	0.000 %	3.8	0.001 %
1 V, 3.30 V	-999.995 mV	-0.001 %		0.001 %
3.29 V, 3.30 V	3.290 V	0.000 %	3.8	0.001 %
3.29 V, 3.30 V 3.29 V, 3.30 V	-3.290 V	0.000 8	3.7	0.001 8
.0 V, 33 V	-3.027 µV	-3.027 µV		20.000 μν
.0 V, 33 V -10 V, 33 V	10.000 V	0.000 %		0.001 %
12.9 V, 33 V	32 900 V	0.000 %		0.001 %
32.9 V, 33 V	-32 900 V	0.000 %	3 6	0.001 %
00 V, 330 V	50.000 V	0.000 %	5.0	0.002 %
129 V, 330 V	329.000 V	0.000 %	3.4	0.002 %
50 V, 330 V	-50.000 V	0.000 %		0.002 %
329 V, 330 V	Measurement 231.169 nW 329.000 nW 329.000 nW 66.681 nW 999.998 nW 999.998 nW -3.029 NW -3.027 µW 10.000 V -3.027 µW 10.000 V -30.027 µW 230.000 V -30.000 V	0.000 %	3.4	0.002 %
34 V, 1 kV	334.002 V	0.001 %		0.002 %
00 V, 1 kV	900.005 V	0.001 %	3.7	0.002 %
.020 kV, 1 kV	1.020 kV	0.001 %	3.7	0.002 %
000 V, 1 kV 020 kV, 1 kV .334 V, 1 kV	-334.002 V	0.000 %		0.002 %
900 V, 1 kV	-900.004 V	0.000 %	3.7	0.002 %
1.020 kV, 1 kV	-1.02000 kV	0.00045 %	3.7	0.00165 %
iux Out/Range				
		-0.014 mV		0.350 mV
129 mV, 300 mV	329.008 mV	0.002 %		0.136 % 0.136 %
329 mV, 300 mV -329 mV, 300 mV 330 mV, 3 V	-329.U32 mV	0.010 %		0.136 %
	329.990 mV	-0.003 %		0.136 %
3.29 V, 3 V	3.290 V	0.001 %		0.041 %
7 V, 7 V	6 999 V	-0.001 %		0.035 %
7 V, 7 V	_6 999 V	-0.000 4		0.035 %
C Current				
Output/Range	Measurement	Deviation	TUR	90 Day Spec
	206.661 pa	0.207 nA		20.000 nA
I A, 300 μA				0.023 %
л A, 300 ра .90 рA, 300 рА	189.996 µA	-0.002 %		
л А, 300 µА .90 µА, 300 µА .190 µА, 300 µА	189.996 μA -189.995 μA	-0.002 % -0.002 %		0.023 %
90 µA, 300 µA 90 µA, 300 µA 190 µA, 300 µA 129 µA, 300 µA	189.996 μA -189.995 μA 328.994 μA	-0.002 % -0.002 % -0.002 %		0.023 % 0.018 %
90 µA, 300 µA .90 µA, 300 µA .190 µA, 300 µA .29 µA, 300 µA .329 µA, 300 µA	189.996 µA -189.995 µA 328.994 µA -328.993 µA	-0.002 % -0.002 % -0.002 %		0.023 % 0.018 % 0.018 %
1 A, 300 μA -190 μA, 300 μA -190 μA, 300 μA -129 μA, 300 μA -329 μA, 300 μA -1 A, 3 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA	-0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA		0.023 % 0.018 % 0.018 % 50.000 nA
1 A, 300 μA -190 μA, 300 μA -190 μA, 300 μA -129 μA, 300 μA -329 μA, 300 μA -340 μA, 3 mA -90 mA, 3 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA	-0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 %		0.023 % 0.018 % 0.018 % 50.000 nA 0.011 %
1 A, 300 μA 190 μA, 300 μA 190 μA, 300 μA 129 μA, 300 μA 329 μA, 300 μA 1 A, 3 mA .190 mA, 3 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA -1.900 mA	-0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 % -0.001 %		0.023 % 0.018 % 0.018 % 50.000 nA 0.011 %
1. A, 300 μA 1.90 μA, 300 μA 1.90 μA, 300 μA 1.29 μA, 300 μA 3.29 μA, 300 μA 3.29 μA, 3 mA 1.90 mA, 3 mA 1.29 mA, 3 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA -1.900 mA	-0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 % -0.001 %		0.023 % 0.018 % 0.018 % 50.000 nA 0.011 % 0.011 %
1 A, 300 μA 90 μA, 300 μA 190 μA, 300 μA 229 μA, 300 μA 329 μA, 300 μA A, 3 mA 1.90 mA, 3 mA 1.90 mA, 3 mA 3.29 mA, 3 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA -1.900 mA 3.290 mA -3.290 mA	-0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 % -0.001 % 0.000 %	2 2	0.023 % 0.018 % 0.018 % 50.000 nA 0.011 % 0.010 % 0.010 %
7.4, 300 µA 90 µA, 300 µA 190 µA, 300 µA 190 µA, 300 µA 329 µA, 300 µA 329 µA, 300 µA 3, 3 mA 1.90 mA, 3 mA 1.29 mA, 3 mA 1.29 mA, 3 mA 1.7, 30 mA 1.7, 30 mA 1.7, 30 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA -1.900 mA 3.290 mA -3.290 mA 26.477 nA 19.000 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 % -0.001 % 0.000 % 0.000 %	2.2	0.023 % 0.018 % 0.018 % 50.000 nA 0.011 % 0.010 % 0.010 % 0.250 uA
7. A, 300 µA 90 µA, 300 µA 130 µA, 300 µA 130 µA, 300 µA 329 µA, 300 µA A, 3 mA 1, 90 mA, 3 mA 1, 29 mA, 3 mA 3, 25 mA, 3 mA 9, mA, 30 mA	189.996 µA -189.995 µA 328.994 µA -328.993 µA -1.900 mA -1.900 mA -3.290 mA -3.290 mA 26.477 nA 19.000 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.000 % -0.001 % 0.000 % 0.000 % 0.000 %	2.2	0.023 % 0.018 % 0.018 % 0.018 % 50.000 nA 0.011 % 0.011 % 0.010 % 0.010 % 0.0250 uA 0.009 %
A, 300 JA, JA, 300 JA, JA, 300 JA, JA, 300 JA, JA, 300 JA, 300 JA, 300 JA, 300 JA, 300 JA, 3, 3 mA, 3, 3 mA,	189.996 µA -189.995 µA 328.994 µA -328.993 µA 1.417 nA 1.900 mA -1.900 mA -3.290 mA -6.477 nA 19.000 mA -19.000 mA -19.000 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 %	2.2 3.6 3.6 3.6	0.023 % 0.018 % 0.018 % 0.018 % 50.000 nA 0.011 % 0.011 % 0.010 % 0.250 uA 0.009 % 0.009 %
A, 300 µA 90 µA, 300 µA 190 µA, 300 µA 190 µA, 300 µA 2329 µA, 300 µA 3, 3 mA 3, 2 mA, 3 mA 3, 2 mA, 3 mA 9, mA, 30 mA 9, mA, 30 mA 19 mA, 30 mA 19 mA, 30 mA	189.996 µA -189.995 µA -189.995 µA -328.993 µA -328.993 µA -1.900 mA -1.900 mA -3.290 mA -3.290 mA -3.290 mA -32.900 mA -39.000 mA -39.000 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 % -0.000 %	2.2 3.6 3.6 3.6 3.5	0.023 % 0.018 % 0.018 % 0.010 % 0.011 % 0.011 % 0.010 % 0.010 % 0.025 uA 0.009 % 0.009 % 0.009 % 0.009 %
A, 300 µA µA A, 300 µA µA A	189.996 juh -189.995 juh -288.994 juh -328.995 juh -328.995 juh -1.910 mA -1.900 mA -1.900 mA -3.290 mA -3.290 mA -19.000 mA -19.000 mA -32.900 mA -32.900 mA -32.900 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.000 % -0.001 % -0.	2.2 3.6 3.6 3.6 3.5	0.023 % 0.018 % 0.018 % 0.018 % 0.010 % 0.011 % 0.011 % 0.010 % 0.010 % 0.010 % 0.010 % 0.009 % 0.009 % 0.009 % 0.009 %
A 3 300 µA 10 µA 1	189.996 juh 328.994 juh 328.994 juh 328.993 juh 1.4017 nh 1.900 mh 1.900 mh 3.290 mh 3.290 mh 3.290 mh 3.290 mh 3.2900 mh 39.000 mh 31.900 mh	-0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.000 % -0.001 % -0.001 % -0.001 % -0.001 % -0.000 % -0.001 % -0.000 % -0.001 % -0.000 % -0.001 % -0.000 % -0.	2.2 3.6 3.6 3.6 3.5	0.023 % 0.018 % 0.018 % 0.018 % 0.018 % 0.000 nA 0.011 % 0.011 % 0.010 % 0.250 uA 0.009 % 0.00
A, 300 µA, 3, 3 mA, 3, 29 mA, 3 mA, 3, 29 mA, 3 mA, 3, 29 mA, 30 mA, 300 mA, 300 mA, 300 mA, 300 mA	189.996 juh -189.995 juh -288.994 juh -328.994 juh -328.993 juh 1.417 nh 1.900 mh -3.290 mh -3.290 mh -3.290 mh -3.290 mh -3.290 mh -3.2900 mh -32.900 mh	-0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.002 % 1.417 nA 0.000 % 0.001 % 0.000 % 0.000 % 0.001 % 0.001 % 0.001 % 0.001 % 0.001 % 0.000 % 0.001 % 0.000 %	2.2 3.6 3.6 3.6 3.5 2.7 2.7	0.023 % 0.018 % 0.018 % 0.018 % 0.010 % 0.011 % 0.011 % 0.011 % 0.010 % 0.250 uA 0.009 % 0.009 % 0.009 % 0.009 % 0.009 % 0.009 % 0.009 %
A, 300 BA A, 300 BA JO BA J	189.996 µA 189.995 µA 328.994 µA 1.417 µA 1.417 µA 1.900 mA 1.900 mA 3.290 mA 3.290 mA 3.290 mA 3.2900 mA 32.900 mA 32.900 mA 32.900 mA 19.000 mA 32.900 mA	-U.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.001 & -0.	2.2 3.6 3.6 3.6 3.5 2.7 2.7 2.6	0.023 % 0.018 % 0.018 % 0.018 % 0.018 % 0.011 % 0.011 % 0.011 % 0.010 % 0.010 % 0.010 % 0.009 % 0.000 % 0.0000 % 0.000 % 0.000 % 0.000 % 0.000 % 0.000 % 0.000 % 0.000 % 0.000
A, 300 µA, 3, 3 mA,	189.996 juh 328.994 juh 328.993 juh 1.417 inh 1.900 mh -1.900 mh -3.290 mh	-U.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.002 & -0.001 & -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.6	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.0250 uA 0.009 s
A, 300 BA A, 300 BA B, 300 BA 29 BA, 300 BA 29 BA, 300 BA A, 3 BA 1, 90 BA, 3 BA 1, 90 BA, 3 BA 1, 90 BA, 3 BA 29 BA, 30 BA 29 BA, 30 BA 29 BA, 30 BA 30 BA 29 BA, 30 BA 20 BA, 30 BA	189.996 juA 328.994 juA 328.994 juA 1.890 paA 1.900 paA 1.900 paA 2.900 paA 2.6477 paA 1.900 mA 2.900 mA 2.900 mA 2.900 mA 32.900 mA	-0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.002 % -0.001 % -0.001 % -0.000 % -0.001 % -0.001 % -0.002 % -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.6 2.7	0.023 % 0.018 % 0.018 % 0.018 % 0.011 % 0.011 % 0.011 % 0.010 % 0.010 % 0.020 % 0.009 %
A, 300 µA, 3 mA, 3	189.995 µA -189.995 µA -189.995 µA -189.995 µA -189.995 µA -1.417 nA -1.900 mA -1.900 mA -2.25 µB -2.2	-0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.000 \$ -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.010 s 0.0250 uA 0.009 s
A, 500 µA, µA, 100 µA, µA, 100 µA, 3 mA, 1.90 mA, 3	189,995 µh 282,994 µh 282,995 µh 328,994 µh 1.417 µh 293,994 µh 1.417 µh 293,994 µh 2.429 µh	-0.002 b -0.002 b -0.002 b -0.002 b -0.002 b -0.000 b -0.	2.2 3.6 3.6 3.5 2.7 2.6 2.6 2.7	0.023 & 0.018 & 0.018 & 0.018 & 0.018 & 0.018 & 0.011 & 0.011 & 0.011 & 0.011 & 0.010
A, 300 µA 300 µA, 300 µA 3190 µA, 300 µA 329 µA, 300 µA A, 300 µA A, 3 m 1, 90 mA, 3 mA 1, 90 mA, 3 mA 1, 90 mA, 3 mA 3, 29 mA, 30 mA 9 mA, 30 mA 9 mA, 30 mA 9 mA, 30 mA 22, 9 mA, 30 mA 22, 9 mA, 30 mA 32, 9 mA, 30 mA 30	189,995 µh	-0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.001 \$ -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.010 s 0.09 s 0.099 s 0.009 s
A, 300 UA,	189.995 µh 282.995 µh 328.994 µh 328.994 µh 1.417 nh 1.900 mh 1.900 mh 2.200 mh 328.994 µh 1.417 nh 1.900 mh 1.900 mh 32.900 mh 32.900 mh 32.900 mh 32.900 mh 32.900 mh 19.000 mh 19.0000 mh 19.000 mh 19.0000 mh 19.000 mh 19.0000 mh 19.000 mh 19.0000 mh	-0.002 b -0.002 b -0.002 b -0.002 b -0.002 b -0.000 b -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.010 s 0.010 s 0.025 uA 0.009 s
.90 mJo Uho Ipo Ipo Ipo Ipo Ipo Ipo Ipo Ipo Ipo Ip	189,996 ju ha 282,994 ju ha 282,994 ju ha 282,994 ju ha 1.99,996 ma ha 1.99,996 ma ha 262,993 ju ha 262,477 na ha	-U. 002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.001 \$ -0.001 \$ -0.001 \$ -0.002 \$ -0	2.2 3.6 3.6 3.5 2.7 2.6 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.009 s
A, 300 JAC	189.995 µh 282.995 µh 328.994 µh 328.994 µh 1.417 µh 1.417 µh 1.417 µh 1.900 mh 1.900 mh 2.200 mh 1.200 mh 1.20	-U. 002 \$ -0.002 \$ -0	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.010 s 0.0250 uA 0.009 s
A 300 JAC	189,996 ja ha 282,994 ja ha 282,994 ja ha 282,994 ja ha 1.417 n ha 1.99 jo ha 282,993 ja ha 1.417 n ha 1.990 m ha 1.990 m ha 26,477 n ha 26,477 n ha 19,000 m ha 26,477 n ha 19,000 m ha 29,900 m ha 189,996 m ha 199,994 m ha 282,992 m ha 110,000 ha 2,2990 ha 11,000 ha 11	-U.002 \$ -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.009 s
A, 300 JAC	189.995 µh 282.994 µh 328.994 µh 328.994 µh 1.417 nh 1.900 mh 1.900 mh 1.900 mh 2.200 mh 2.200 mh 2.200 mh 2.200 mh 22.200 mh	-U.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.000 \$ -0.	2.2 3.6 3.6 3.5 2.7 2.6 2.6 2.7	0.023 s 0.018 s 0.018 s 0.018 s 0.018 s 0.011 s 0.011 s 0.011 s 0.011 s 0.010 s 0.010 s 0.0250 uA 0.009 s
V, 7 V V, 7 V Courrent Courrent 1, 20 Courrent 1, 2	189,996 ja ha 282,998 ja ha 282,994 ja ha 282,993 ja ha 1.417 na ha 1.900 ma ha 1.900 ma ha 1.900 ma ha 26.477 na ha 26.477 na ha 26.477 na ha 27.000 ma 32.900 ma 32.900 ma 32.900 ma 32.900 ma ha 32.900 ma 32.900 ma ha 189,996 ma 1.900 ma ha	-U 002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.002 \$ -0.000 \$ -0.	2.2 3.6 3.6 3.5 2.7 2.7 2.6 2.7	0.023 & 0.018 & 0.018 & 0.018 & 0.018 & 0.018 & 0.018 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.011 & 0.009





Accredited by the National Voluntary Laboratory Accreditation Program for the specific Scope of accreditation under Lab Code 105016-0.

FLUKE ® Fluke Corporation Everett, Washington 98206 USA

Traceability Information

Factory Annex of the Primary Standards Laboratory



Calibration Certificate

Description:	Multi-Function Calibrator	Certificate Number:	Sample
Manufacturer:	Fluke	Date of Calibration:	23-Feb-2007
Model:	5720A	Date of Certificate:	05-Mar-2007
Serial number:	XXXXXXX	Temperature:	23 ± 3 °C
Customer Name:	Fluke Corporation	Relative Humidity:	Less than 70% RH
City, State:	Everett, WA		
Procedure Name:	5720A-150		

This calibration certificate may contain data that is not covered by the NVLAP Scope of Accreditation. The unaccredited material, where applicable, is indicated by an asterisk (*) or confined to clearly marked sections.

Measurement uncertainties at the time of test are calculated in accordance with the method described in NIST TN1297, for a confidence level of 95% using a coverage factor of approximately k=2.

In the attached measurement results deviation may be expressed with units, Measured Value (MV) – Nominal Value (NV) or as a proportion of the nominal value ((NV-NV)/NV), expressed as percent.

This calibration certificate applies only to the item identified and shall not be reproduced other than in full, without specific written approval by Fluke Corporation. The user is obliged to have the object recalibrated at appropriate intervals. This certificate shall not be used to claim product endorsement by NVLAP or any agency of the U.S. Government. Calibration certificates without signatures are not valid.

Fluke's calibration system complies with the requirements of ANSI/NCSL Z540A.1-1994 (R2002) and ISO/IEC 17025:2005

Technician	Factory Annex Deputy
------------	----------------------

			Page 1 of 5
Fluke Corporation	425.446.6378	Fax 425.446.5649	www.fluke.com

Date of Certificate: 05-Mar-2007

Page 2 of 5

This calibration was conducted using an unbroken chain of standards to the Fluke Volt, which is traceable to the U.S. representation of the volt, through the internationally accepted value of the Josephson constant Kj-483597.9 GHz/V and a 10 Volt Josephson Array Voltage Standard. Frequency This calibration was conducted using an unbroken chain of standards to a GPS disciplined oscillator frequency standard, traceable to the United States Naval Observatory (USNO), which is traceable to the National Institute of Standards and Technology (NIST). AC Voltage (1 MHz and below), Resistance, DC Current, AC Current (10 mA and above), Capacitance, Inductance and Phase This calibration was conducted using an unbroken chain of standards which are traceable to NIST or the National Research Council Canada (NRC). AC Voltage (1 MHz) and RF Power This calibration was conducted using an unbroken chain of standards which are traceable to NIST or the National Research Council Canada (NRC). AC Current (1 mA) This calibration was conducted using an unbroken chain of standards which are traceable to Physikalisch Technische Bundesanstalt (PTB) (German National Metrology Institute). Turpezture The calibration was conducted using an unbroken chain of standards to the Hart Scientific Metrology Laboratory, which is traceable to NIST andror to Hart maintained intrinsic standards. Humidity This calibration was conducted using an unbroken chain of standards to the Hart Scientific Metrology Laboratory, which is traceable to NIST andror to Hart maintained intrinsic standards. Humidity This calibration was conducted using an unbroken chain of standards traceable to the Fluke Everett Service Center, whose traceable is to based on the physical phenomena in which the equilibrium relative humidity values associated with certain saturated salt solutions are known.

Accredited report of calibration

This calibration certificate documents that a specific instrument was calibrated in a manner traceable to national and international standards, in accordance with the practices defined in the international standard ISO/ IEC 17025. (Specifically, its present version is ISO/IEC 17025:2005). The report identifies the instrument tested by model and serial number. The testing used Fluke's applicable procedures. Details of the individual tests are provided with a variety of supporting information. These details may include some or all of, but are not limited to, the specific test points, measured values, the appropriate specification limits, measurement uncertainty, etc. Also included are specific testing dates, specific testing instrumentation details, traceability information, and refers to the 17025 accreditation body with accreditation details. An example of this document is included in Figure 5.

Certificate Number: Sample	Date of Certificate: 05	-Wai-2007	Page	3 01 3
Standards Used				
DN47				
DC Voltage	W	B		04 11 0
Output/Range	measurement	Deviation	uncertainty	24 Hour Spec
0 1/ 2 2 1/	-0.30 dV	0.30 uv	0.21 07	0.00 uv
0 17 11 17	- VI 11.0-	-0.11 uv	0.10 07	2 0 117
0 1, 11 1	-0.5 dV	-0.5 uv	1.0.01	5.0 µv
0 1, 22 1	-0.0 dV	-0.0 uv	1.0 µV	5.0 pv
0 V, 220 V	-21 µV	-21 µV	0 0005 %	0 0010 %
100 mV, 220 mV	99.9990 MV	0.0004 %	0.0003 %	0.0010 %
1 U 2 2 U	0.00000011	-0.0002 %	0.0007 %	0.0010 8
_1 V 2 2 V	-1 0000005 V	0.00000030 %	0.0001207 8	0.0004300 \$
-1 V, 2.2 V	9 999998 17	_0.00000473 %	0.0001200 %	0.0004300 %
10 1/ 11 1/	0.000007 V	0.000020 %	0.000070 %	0.000200 %
10 V, 11 V	10 000001 V	0.0000030 %	0.0000070 %	0.000200 %
-10 V 22 V	-10 0000001 V	0.000015 %	0.000070 %	0.000300 %
100 V. 220 V	99,99999 17	-0.000003 %	0.000070 %	0.00040 %
-100 V. 220 V	-100.00001 V	0.00001 %	0.00010 %	0.00040 %
1 kV. 1.1 kV	1.0000010 kV	0.0000997 %	0.0001400 %	0.0005500 %
DC Voltage Dutput/Range 0 V, 220 mV 0 V, 212 V 0 V, 11 V 0 V, 212 V 0 V, 212 V 1 V 0 V, 22 V 1 V 1 V 1 V 1 V 1 V 1 V 1 V 1 V 1 V 1	-1.0000008 kV	0.0000842 %	0.0001400 %	0.0005500 %
-1 kV, 1.1 kV Resistance Output 0 G 0 G 1999.890 mG 1.89981 G 1.89981 G 1.89981 G 1.89981 G 1.89981 G 1.89981 G 1.99997 G 1.990.001 G 1.900.003 G 1.900.003 G 1.900.003 KG 1.9				
Jucpuc	Measurement	Deviation	uncertainty	24 nour Spec
U M	-8 μΩ	-8 μΩ	ο οος τ	50 ps
999.890 mL1	999.874 mL2	-0.002 %	0.002 %	0.009 %
1.89981 12	1.89983 Ω	0.00109 %	0.00202 %	0.00850 %
9.99903 12	9.99957 12	-0.00059 &	0.00100 &	0.00230 %
18.999/4 Ω	18.99963 Ω	-0.00058 %	0.00085 %	0.00230 %
100.0003 12	100.0005 12	0.0001 4	0.0003 %	0.0010 %
1 0000400 10	1 0000404 50	0.0001 %	0.0003 %	0.0010 %
1 0000400 kg	1 0000444 KQ	0.00000427 %	0.0003132 %	0.00000000 %
0 000087 50	1.900065 KΩ	0.000231 %	0.000418 #	0.000800 %
10 00000 10	10 00000 10	0.000020 %	0.000200 6	0.000000 %
00 00046 00	19.00080 KD	0.00003 %	0.00025 6	0.00090 %
189.9923 kO	189.9925 10	0.0001 2	0.00033 %	0.0009 %
999.985 kO	999.987 10	0.000 2	0.000 %	0.002 %
1.899927 MΩ	1.899927 MO	0.000013 %	0.000477 %	0.001700 %
9.99904 MO	9.99904 MO	0.00005 %	0.00102 %	0.00330 %
18.99941 MΩ	18.99925 MO	-0.00082 %	0.00105 %	0.00430 %
100.010 MΩ	100.009 MΩ	-0.001 %	0.006 %	0.010 %
MC Voltage Dutput/Prequency Dutput/Prequency 19 mV, 20 kHz 19 mV, 20 kHz 19 mV, 10 kHz 190 mV, 10 kHz 190 mV, 20 kHz 190 mV, 1 kHz 190 mV, 1 kHz 190 mV, 1 kHz 190 mV, 10 kHz 190 mV, 10 kHz 190 mV, 10 kHz 100 mV, 10 kHz				
output/Frequency	Measurement	Deviation	Uncertainty	24 Hour Spec
1.7 mv, 1 KHZ	1.0993 MV	-0.036/%	0.0964 %	0.2/10 6
1.7 mV, ZU KHZ 19 mU 40 H2	1.0998 MV	-0.0091 %	0.1230 %	0.2/10 6
10 mV 1 bH2	10.55/2 MV	-0.0149 %	0.0050 %	0.0340 %
19 mV. 20 kHz	18.9990 wt/	-0.0139 6	0.0090 %	0.0348 %
19 mV 100 kH2	18 900 m7	-0.0031 %	0.0000 %	0.0040 %
19 mV. 300 kHz	18 906 wt/	-0.003 %	0.028 6	0.163 %
19 mV, 1 MHz	18.954 mV	-0.244 %	0.110 %	0.422 %
190 mV, 40 Hz	190.003 mV	0.002 %	0.003 %	0.013 %
190 mV, 1 kHz	189.999 mV	-0.001 %	0.006 %	0.013 %
190 mV, 20 kHz	190.000 mV	0.000 %	0.008 %	0.013 %
190 mV, 100 kHz	190.00 mV	0.00%	0.01 %	0.06 %
190 mV, 300 kHz	190.00 mV	0.00 %	0.02 %	0.10 %
190 mV, 1 MHz	189.97 mV	-0.02 %	0.07 %	0.30 %
600 mV, 40 Hz	599.995 mV	-0.001 %	0.003 %	0.006 %
600 mV, 1 kHz	599.994 mV	-0.001 %	0.002 %	0.006 %
600 mV, 20 kHz	600.002 mV	0.000 %	0.002 %	0.006 %
600 mV, 100 kHz	600.03 mV	0.01 %	0.01 %	0.02 %
600 mV, 300 kHz	599.95 mV	-0.01 %	0.01 %	0.05 %
600 mV, 1 MHz	599.4 mV	-0.1 %	0.1 %	0.2 %
1 V, 40 Hz	1.00001 V	0.00057 %	0.00200 %	0.00550 %
Fluke Corporation				

Figure 5. Accredited report of calibration



Common questions

What are the documentary standards that reference the standard practices and requirements of calibration?

There are a number of formal documents that influence calibration practices and calibration certificates. A partial list of the more common of these is shown below, with a simple description.

ISO/IEC 17025

This refers to the international standard for General Requirements for the Competence of Testing and Calibration Laboratories. Originally published in 1999, the present version was revised in 2005. Its requirements are the basis for which present day calibration and testing laboratories are measured.

ANS/NCSL Z540.1

This refers to the American National Standard for Calibration Laboratories and Measuring and Test Equipment-General Requirements. It is based on the ISO/IEC Guide 25 as well as on MIL-STD 45662A, which was included to meet U.S. Department of Defense requirements. Originally published in 1994, it is scheduled to expire in 2007.

ISO 9000

This refers to the international standard for quality management systems. It covers a wide range of topics. Included are specific directions requiring the consideration of both the management and the calibration of the testing equipment which are involved in the quality processes of an organization. With respect to calibration, ISO 9000 is a philosophical standard rather than a technical one. Specific calibration certificate requirements are determined by the individual organization and its quality systems. To satisfy any technical and operational requirements for calibration, it is best to refer to other standards, such as those also mentioned in this section.

ISO Guide 25

This refers to the international guide for general requirements for the competence of calibration and testing laboratories. This is guide is now obsolete and has been replaced by ISO/IEC 17025.

MIL-STD 45662A

This refers to a military standard on calibration system requirements. This MIL-STD was originally intended to meet U.S. Department of Defense requirements. This standard is obsolete. Its requirements are still met through Z540.1 Part 2, and somewhat by ISO 10012-1, Quality Assurance Requirements for Measuring Equipment.

Why do there seem to be different types of 17025 Accredited Calibration Certificates or Reports?

Any calibration lab or testing organization providing such a calibration must be audited, approved, and certified to conform to the 17025 standard. This auditing is performed by any of a number of different organizations which are authorized to audit whether or not calibration laboratories meet the 17025 requirements. These auditing organizations reside in various countries who participate in the Mutual Recognition Agreement. These organizations and their accreditation assessments are internationally recognized outside of their country of origin through international agreements.

Once a lab has been certified, the specific accrediting organization's approval is referenced in the calibration certificate. Hence, the name of the accrediting organization will often be identified with the calibration certificate. This means there are several types of certificates, but all are considered equal as they conform to the requirements of the same international standard.

Examples of 17025 accredited calibration certificates include:

- **NVLAP accredited calibration certificate.** This certificate confirms the testing was done in a manner approved by the USA's calibration accrediting body named the National Voluntary Laboratory Accreditation Program.
- **UKAS** accredited calibration certificate. This certificate confirms the testing was done in a manner approved by the UK's calibration accrediting body named the United Kingdom Accreditation Service.
- **A2LA accredited calibration certificate.** This certificate confirms the testing was done in a manner approved by the USA's calibration accrediting body named the American Association for Laboratory Accreditation.

There are many other accreditation bodies authorized to accredit laboratories for 17025, represented in nearly all developed countries throughout the world. The names and acronyms for some of these bodies include:

- **CLAS.** Canadian Lab Accreditation System (Canada)
- **DKD.** Deutscher Kalibrierdienst, German Laboratory Association (Germany)
- IAJapan JCSS. International Accreditation Japan, Japan Calibration Service System (Japan)
- **NATA.** National Association of Testing Authorities (Australia)
- RvA. Raad voor Accreditatie, Dutch Accreditation Council (Netherlands)
- **SAC-SINGLAS.** Singapore Accreditation Council - Singapore Laboratory Accreditation Scheme (Singapore)



Common questions

What certificates come standard with a newly purchased instrument?

Generally, all Fluke instruments come with either a formal calibration certificate or a statement of calibration practices. General purpose test instruments commonly come with a statement of calibration practices. A formal calibration certificate is optional. On the other hand, calibration instruments commonly include some type of a traceable calibration certificate with data. When other certificates are required, then other specific calibrations with specific types of certificates may be performed as an option.

Do all new instruments need a calibration certificate?

It is highly recommended that an instrument be calibrated and have evidence of such through an appropriate certificate. The quality management system standard ISO 9000 states that prior to its use, an instrument should be calibrated using traceable standards to insure its proper performance. Depending upon the instrument user's requirements, the specific type of calibration and the associated certificate can be determined.

What about a calibration certificate for an existing instrument?

It is important to routinely calibrate existing test instruments during their useful life. The performance of all instruments changes with time, and certificates valid at the time they are new must replaced with valid certificates on a regular basis during the lifetime of an instrument. (Typically this is yearly, or alternatively at an interval that is set to be at an acceptable level risk against undetected instrument failures.) It is also a requirement for calibration after an instrument is repaired. When an instrument is returned for routine calibration or repair and recalibration, it is important to specify the appropriate type of calibration certificate required.

What is traceability?

The term traceability refers to an unbroken chain of measurements relating an instrument's measurements to a known standard. These measurements are realized through an unbroken chain of comparisons from the measurement being made, back to a recognized national and legal standard. Traceability insures that all measured parameters eventually trace back to an appropriate fundamental international system unit of measurement (the SI unit). In practice, the instrument is being calibrated with a calibration standard that can be proven as traceable is to a national standard. This national standard in turn is traceable to an international standard. This traceability chain is used to certify an instrument's accuracy relative to a known and accepted standard. The calibration certificate is documentary proof of traceability for a particular instrument.

Will a calibration certificate originating in another country, and possibly accredited by a foreign organization, be acceptable as traceable in my country?

Simply speaking, calibrations which are properly accredited as meeting ISO/IEC 17025 will satisfy the requirements to be internationally acceptable. There should be no need to recertify or recalibrate an instrument with such a calibration certificate to satisfy local authorities of proper traceability to international standards.

Specifically, an international agreement has been signed between the National Metrology Institutes (NMIs) of most developed countries worldwide. This Mutual Recognition Arrangement (MRA) provides for acceptance of the national measurement standards and for calibration and measurement certificates issued by NMIs. This acceptance is further expanded to the test and calibration certificates made by other laboratories traceable to NMIs, provided these laboratories have been accredited through the processes defined as acceptable under international agreement.

On the other hand, calibration certificates that are not accredited to meet ISO/IEC 17025 may or may not be found acceptable as traceable to national and international standards. No formal agreements of acceptance for such certificates exist. It is up to instrument owner and the local authorities to decide on the acceptability of such calibration reports.



Common questions

How can I ensure I get a particular type of calibration for my instrument?

When you either (1) purchase a new instrument or return it for (2) recalibration or (3) repair and recalibration, you should inquire about what type of documented calibrations are available from that servicing laboratory. Make sure the laboratory is capable and has the authority to provide the calibration your organization requires. Also, it is often necessary to have a report of the instrument's performance as measured when it arrives at a laboratory (commonly termed "As Found" data), and also supplied with performance data as measured when it leaves the laboratory (commonly termed "As Left" data). With this full set of data you can ensure that any present or future performance deemed marginal or faulty is properly identified for appropriate corrective actions.

What are "as found" data and "as left" data?

Several different measurement test data types can be found on certificates. They can be interpreted as:

- As found. Calibration data collected before the unit is adjusted and/or repaired.
- As left. Calibration data collected after the unit is adjusted and/or repaired.
- As found/as left. Calibration data collected without any adjustment and/or repair performed.

It is important for instruments that are being routinely recertified, or certified following a repair, to have the as found data documented as well the as left data documented. In this way, the complete performance profile of the calibrated instrument is known, and any future corrective actions can be more easily taken. Both as found/as left data are provided with 17025 certificates, but it is not necessarily included in Z540 certificates unless requested.

Are the procedures identical for producing 17025 and Z540.1 calibration certificates for a specific instrument?

In concept, both procedures should be identical or nearly identical. However differences can and do exist. These could be based on differences in the lab's equipment or metrology processes for one procedure vs. the other. Also, the measurement uncertainty calculation processes required in 17025 calibrations might cause the measurement process to be different than the process used in Z540 calibrations. For example, the number of measurements taken and analyzed at each test point could be different between the two types of calibration procedures.

However, both procedures will be appropriate and adequate to provide a proper calibration report per their individual requirements.

What calibration certificate does Fluke recommend?

As a general practice, Fluke does not recommend one certificate over another. It is up to the user of the instrument to determine what is appropriate for the quality and metrology processes which support their product or service. It is important to be consistent. For example, a laboratory which supplies 17025 accredited calibrations to their customers should obtain similar 17025 accredited calibrations for their instruments.

If there is some doubt on what type of calibration report is needed, it is good practice to obtain the more formal 17025 calibration certificate over less stringent calibration certificate alternatives. This ensures the highest quality and best situation to minimize an organization's risk against providing unreliable test results, services and/or products for their end customer's expectations.

Fluke. Keeping your world up and running.®

Fluke Corporation

PO Box 9090, Everett, WA USA 98206 Fluke Europe B.V.

PO Box 1186, 5602 BD Eindhoven, The Netherlands

For more information call: In the U.S.A. (800) 443–5853 or Fax (425) 446–5116 In Europe/M-East/Africa +31 (0) 40 2675 200 or Fax +31 (0) 40 2675 222 In Canada (800) 36–FLUKE or Fax (905) 890–6866 From other countries +1 (425) 446–5500 or Fax +1 (425) 446–5116 Web access: http://www.fluke.com

©2007 Fluke Corporation. All rights reserved. Printed in U.S.A. 6/2007 3029357 D-EN-N Rev A Pub_ID: 11249-eng Rev 01